

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination VAN LITH ET AL.	
		Examiner Marcus Charles	Art Unit 3682	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP (63-280946) A	11-1998	Japan	Kino et al.	474/242
	O					
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NON-PATENT DOCUMENTS

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